Notice of References Cited Application/Control No. O9/422,528 Examiner Christian L. Fronda Applicant(s)/Patent Under Reexamination LEUNG ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

	TOTAL ATENIA DOCUMENTO						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U	Wick et al. Infect Immun. 1993 Nov;61(11):4848-56.					
	>	Balbas et al. Gene. 1996 Jun 12;172(1):65-9.					
	w						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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